Search Notes		

Application/Control No.	Applicant(s)/Patent Reexamination	under
10/672,161	CHUN ET AL.	
Examiner	Art Unit	
Albert Wang	2115	_

SEARCHED				
Class	Subclass	Date	Examiner	
713	300	12/5/2005	AW	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	12/5/2005	AW	